

Notice of References Cited	Application/Control No. 09/932,664	Applicant(s)/Patent Under Reexamination DEGUCHI, YUICHIRO	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Janik et al, US Patent Application 2002/0164973 A1, Nov. 7, 2002.
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